

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEUKER ET AL.	
		Examiner Javid A. Amini	Art Unit 2628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,329,319 A	07-1994	Sgrignoli, Gary J.	348/733
*	B	US-5,432,557 A	07-1995	Hamann et al.	375/240.01
*	C	US-5,485,554 A	01-1996	Lowitz et al.	358/1.17
*	D	US-5,801,777 A	09-1998	Lyu, Hwa-Young	375/240.15
*	E	US-5,818,419 A	10-1998	Tajima et al.	345/691
*	F	US-6,304,604 B1	10-2001	Adiletta et al.	375/240.18
*	G	US-6,326,958 B1	12-2001	Gorny et al.	345/204
*	H	US-2002/0030691 A1	03-2002	McKnight et al.	345/602
*	I	US-6,373,497 B1	04-2002	McKnight et al.	345/602
*	J	US-2002/0159526 A1	10-2002	Hekstra, Gerben Johan	375/240.15
*	K	US-2003/0071831 A1	04-2003	Beuker et al.	345/690
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/00959	01-2000	JP	Park et al.,	G09G 3/24
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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